Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

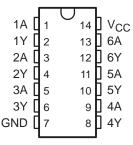
These devices contain six independent hex inverters. They perform the Boolean function  $Y = \overline{A}$ .

The SN54ALS04B and SN54AS04 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS04B and SN74AS04 are characterized for operation from 0°C to 70°C.

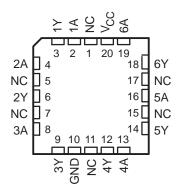
FUNCTION TABLE (each inverter)

INPUT A	OUTPUT Y
Н	L
L	н

#### SN54ALS04B, SN54AS04 . . . J PACKAGE SN74ALS04B, SN74AS04 . . . D OR N PACKAGE (TOP VIEW)



# SN54ALS04B, SN54AS04 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

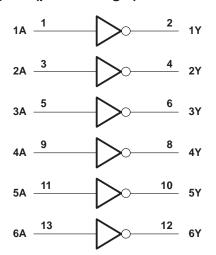
#### logic symbol†

1A	1	1	2 1	Υ
	3	'	4	Y Y
2A	5		l 6	
3A	9		8	Y
4A	11		l 10	Y
5A	13		12	Y
6A			<u> </u>	Y

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

### logic diagram (positive logic)



## SN54ALS04B, SN54AS04, SN74ALS04B, SN74AS04 HEX INVERTERS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, TA: SN54ALS04B	55°C to 125°C
SN74ALS04B	0°C to 70°C
Storage temperature range	. −65°C to 150°C

#### recommended operating conditions

		SN54ALS04B			SN	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			2			V
V	Low lovel input veltage			0.8‡			0.8	V
VIL	Low-level input voltage			0.7§				V
loh	High-level output current		-0.4		-0.4	mA		
I <sub>OL</sub>	Low-level output current	4				8	mA	
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C

<sup>‡</sup> Applies over -55°C to 70°C temperature range

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST COMPLIANC		SN54ALS04B			SN74ALS04B			UNIT
PARAMETER	IESI CI	TEST CONDITIONS		TYP¶	MAX	MIN	TYP¶	MAX	UNII
VIK	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2			-1.2	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2			V <sub>CC</sub> -2	2		V
VOL	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	V
VOL		$I_{OL} = 8 \text{ mA}$					0.35	0.5	٧
lį	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
I <sub>IL</sub>	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA
IO <sup>#</sup>	$V_{CC} = 5.5 V,$	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
<sup>I</sup> ссн	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0		0.65	1.1		0.65	1.1	mA
ICCL	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 4.5 V		2.9	4.4		2.9	4.2	mA

<sup>¶</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> Applies over 70°C to 125°C temperature range

<sup>#</sup>The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

#### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, $R_L$ = 500 $\Omega$ , $T_A$ = MIN to MAX $^{\dagger}$				UNIT
			SN54A	LS04B	SN74AI	LS04B	
			MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	Δ	V	3	17	3	11	ns
<sup>t</sup> PHL	PHL A	Ť	2	13	2	8	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	 7 V
nput voltage, V <sub>I</sub>	 7 V
Operating free-air temperature range, TA: SN54AS04	
SN74AS04	 0°C to 70°C
Storage temperature range	 -65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN54AS04			S	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
loh	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	SN54AS04			SN74AS04		
PARAMETER	lESI C	ONDITIONS	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
V <sub>OH</sub>	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -2			V <sub>CC</sub> -2	2		V
$V_{OL}$	$V_{CC} = 4.5 V,$	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V
lį	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 2.7 V			20			20	μΑ
I <sub>IL</sub>	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0.4 V			-0.5			-0.5	mA
ΙΟ <sup>¶</sup>	$V_{CC} = 5.5 V,$	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA
Іссн	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0		3	4.8		3	4.8	mA
<sup>I</sup> CCL	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 4.5 V		14	26.3		14	26.3	mA

<sup>§</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.



The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, Ios.

# SN54ALS04B, SN54AS04, SN74ALS04B, SN74AS04 HEX INVERTERS

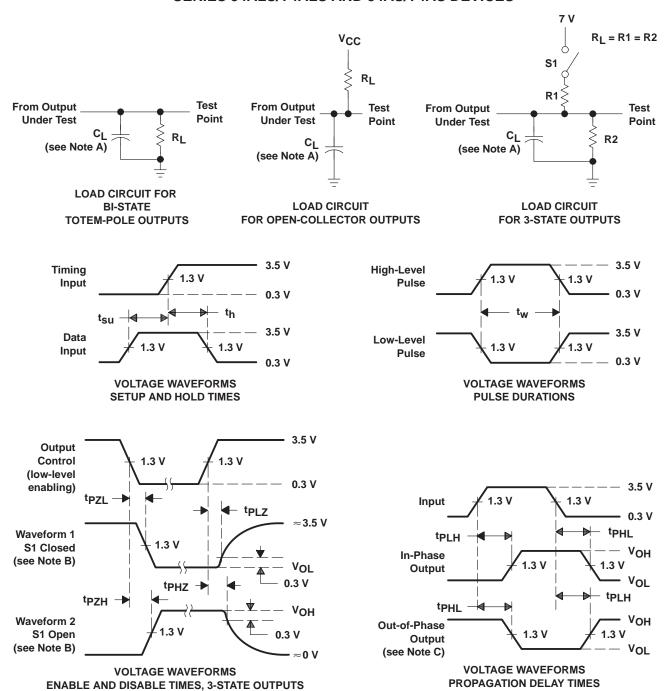
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## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, $R_L$ = 500 Ω, $T_A$ = MIN to MAX <sup>†</sup> SN54AS04 SN74AS04				UNIT
			MIN	MAX	MIN	MAX	
			141114	IVIAA	171114	WAA	
<sup>t</sup> PLH	A	Y	1	6	1	5	ns
<sup>t</sup> PHL	٨		1	4.5	1	4	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_{\Gamma}$  =  $t_{f}$  = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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